

Notice of References Cited	Application/Control No. 10/587,890		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner SUNIL CHACKO		Art Unit 4146	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,044,372	03-2000	Rothfus et al.	707/10
*	B	US-6,307,640	10-2001	Motegi, Akihiko	358/1.14
*	C	US-4,843,571	06-1989	Notermans et al.	358/1.18
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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